

## N-Channel Enhancement Mode Power MOSFET

### DESCRIPTION

The HM4302B uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

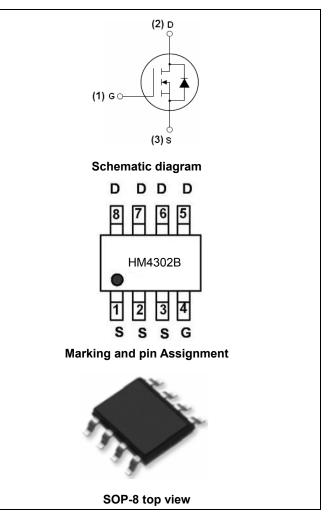
## **GENERAL FEATURES**

• $V_{DS}$  =30V,I<sub>D</sub> =25A  $R_{DS(ON)} < 5.5m\Omega @ V_{GS}$ =10V  $R_{DS(ON)} < 7.0m\Omega @ V_{GS}$ =5V

- High density cell design for ultra low Rdson
- Fully characterized Avalanche voltage and current

### Application

- Power switching application
- Hard Switched and High Frequency Circuits
- Uninterruptible Power Supply



#### Package Marking And Ordering Information

Device Marking	Device	Device Package	Device Package Reel Size		Quantity	
HM4302B	HM4302B	SOP-8	Ø330mm	12mm	2500 units	

#### Absolute Maximum Ratings (TA=25<sup>°</sup>C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	30	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	Ι <sub>D</sub>	25	А
Drain Current-Continuous(T <sub>A</sub> =100°C)	I <sub>D</sub> (100℃)	17.5	А
Pulsed Drain Current	I <sub>DM</sub>	75	А
Maximum Power Dissipation	PD	3	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> ,T <sub>STG</sub>	-55 To 150	°C

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient(Note 2)	R <sub>0JA</sub>	42	°C/W
---	------------------	----	------



#### Electrical Characteristics (TA=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	30	33	-	V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA	
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20V, $V_{DS}$ =0V	-	-	±100	nA	
On Characteristics (Note 3)	· ·		•				
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1	1.3	3	V	
Drain-Source On-State Resistance	P	V <sub>GS</sub> =10V, I <sub>D</sub> =13A	-	4.0	5.5	- mΩ	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =5V, I <sub>D</sub> =13A	-	5.5	7.0		
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =5V,I <sub>D</sub> =25A	5	-	-	S	
Dynamic Characteristics (Note4)							
Input Capacitance	Clss		-	2100	-	PF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz	-	460	-	PF	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	230	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t <sub>d(on)</sub>		-	20	-	nS	
Turn-on Rise Time	tr	V <sub>DD</sub> =10V,I <sub>D</sub> =13A	-	15	-	nS	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10V, $R_{GEN}$ =2.7 $\Omega$	-	60	-	nS	
Turn-Off Fall Time	t <sub>f</sub>		-	10	-	nS	
Total Gate Charge	Qg	)/ _10)/  _104	-	41	-	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}=10V, I_{D}=10A,$	-	14	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =10V	-	11	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =13A	-	-	1.2	V	
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	25	А	

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

**2.** Surface Mounted on FR4 Board, t  $\leq$  10 sec.

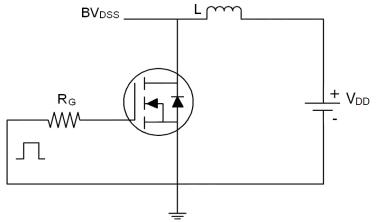
**3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

4. Guaranteed by design, not subject to production

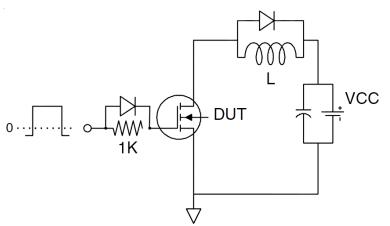


# **Test circuit**

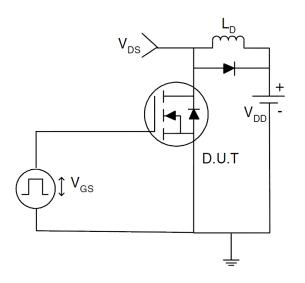
1) E<sub>AS</sub> test Circuits



2) Gate charge test Circuit:

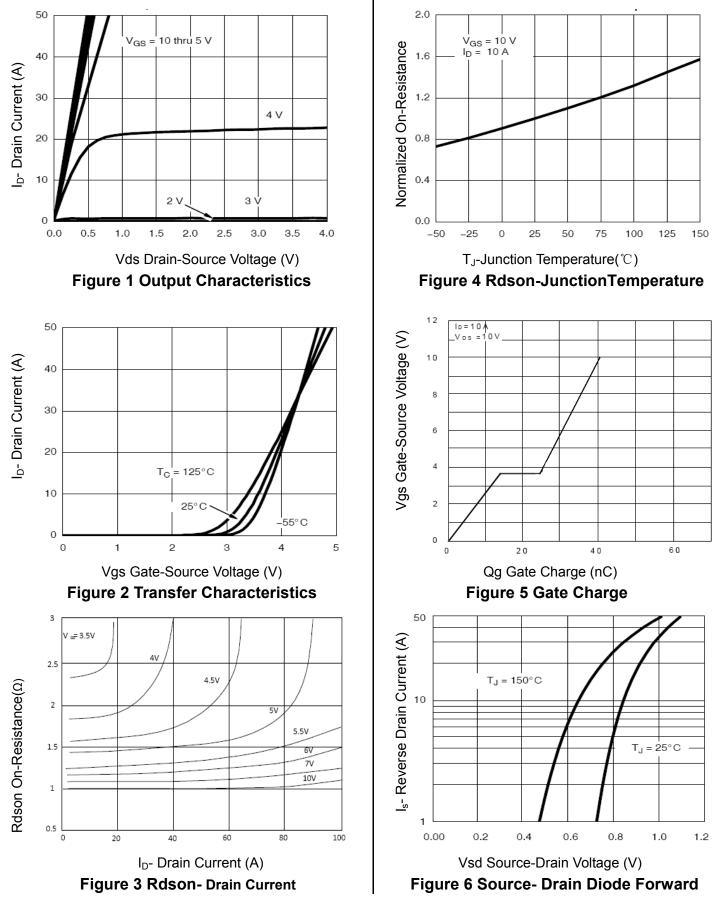


3) Switch Time Test Circuit:





## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)





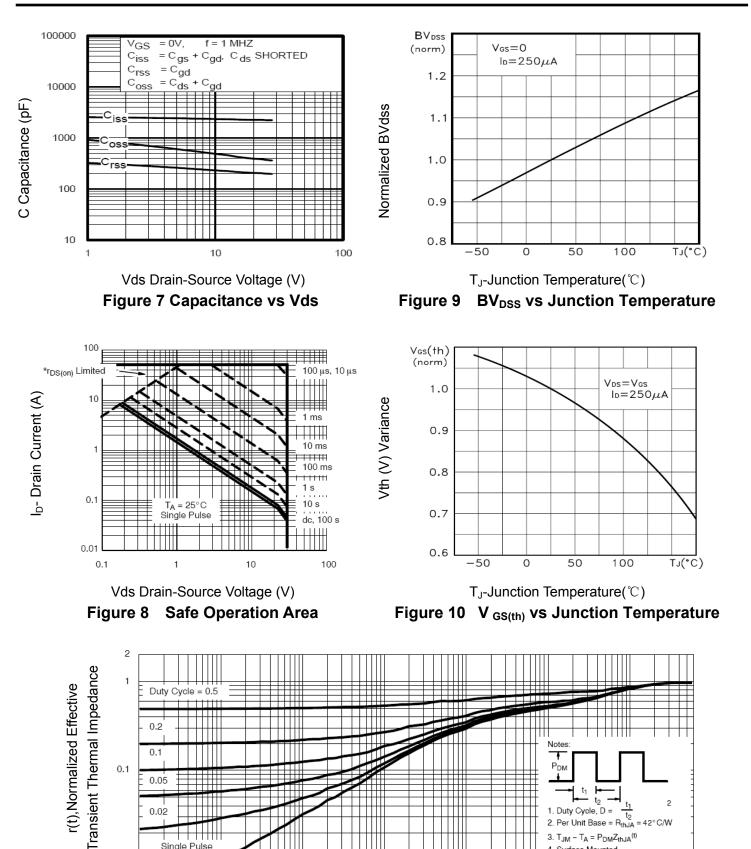
0.02

0.01

10-4

Single Pulse

1 + 1 + 110-3



10-1

Square Wave Pluse Duration(sec) Figure 11 Normalized Maximum Transient Thermal Impedance

1

10-2

t<sub>2</sub>

2. Per Unit Base = RthJA

3.  $T_{JM} - T_A = P_{DM}Z_{thJA}^{(t)}$ 

1. Duty Cycle, D =

4. Surface Mounted

10

t1

t<sub>2</sub>

100

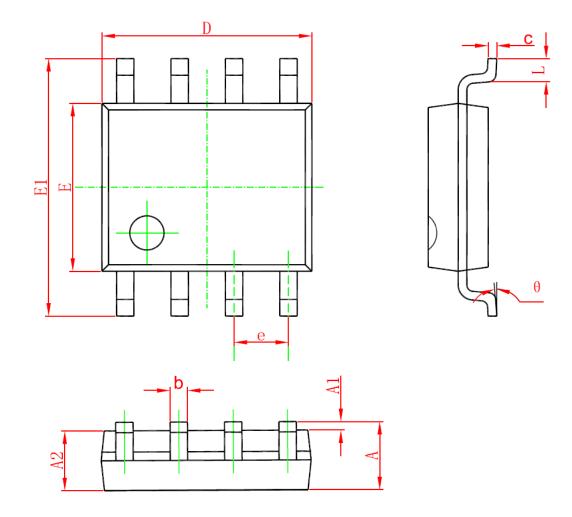
2

600

= 42° C/W



# **SOP-8 PACKAGE IN FORMATION**



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1. 750	0.053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0.053	0. 061	
b	0. 330	0. 510	0.013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4.000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1. 270	0.016	0. 050	
θ	0°	8°	0°	8°	



## ATTENTION:

- Any and all H&M SEMI products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your H&M SEMI representative nearest you before using any H&M SEMI products described or contained herein in such applications.
- H&M SEMI assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all H&M SEMI products described or contained herein.
- Specifications of any and all H&M SEMI products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- H&M Semiconductor CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all H&M SEMI products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of H&M Semiconductor CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. H&M SEMI believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the H&M SEMI product that you intend to use.
- This catalog provides information as of Sep.2010. Specifications and information herein are subject to change without notice.